TOSHIBA 2SK2550

TOSHIBA FIELD EFFECT TRANSISTOR SILICON N CHANNEL MOS TYPE (π -MOS V)

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HIGH SPEED, HIGH CURRENT SWITCHING APPLICATIONS CHOPPER REGULATOR, DC-DC CONVERTER AND MOTOR DRIVE **APPLICATIONS**

Low Drain-Source ON Resistance : $R_{DS(ON)} = 24m\Omega$ (Typ.)

High Forward Transfer Admittance : $|Y_{fs}| = 27S$ (Typ.)

Low Leakage Current : $I_{DSS} = 100 \mu A$ (Max.) ($V_{DS} = 50 V$)

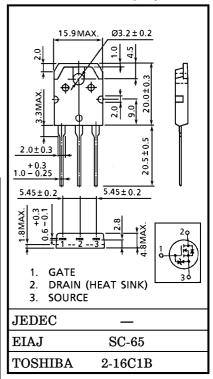
: $V_{th} = 1.5 \sim 3.5 \text{V (V}_{DS} = 10 \text{V, I}_{D} = 1 \text{mA})$ Enhancement-Mode

MAXIMUM RATINGS (Ta = 25°C)

CHARACTERIST	SYMBOL	RATING	UNIT	
Drain-Source Voltage	$V_{ m DSS}$	50	V	
Drain-Gate Voltage (RGG	$v_{ m DGR}$	50	V	
Gate-Source Voltage	v_{GSS}	±20	V	
Drain Current	DC	$I_{\mathbf{D}}$	45	A
	Pulse	$I_{ m DP}$	135	A
Drain Power Dissipation	$P_{\mathbf{D}}$	100	W	
Single Pulse Avalanche	EAS	115	mJ	
Avalanche Current	I_{AR}	45	A	
Repetitive Avalanche En	$\mathbf{E_{AR}}$	10	mJ	
Channel Temperature	$\mathrm{T_{ch}}$	150	°C	
Storage Temperature Range		$\mathrm{T_{stg}}$	-55~150	$^{\circ}\mathrm{C}$

INDUSTRIAL APPLICATIONS

Unit in mm



Weight: 4.6g

THERMAL CHARACTERISTICS

CHARACTERISTIC	SYMBOL	MAX.	UNIT
Thermal Resistance, Channel to Case	R _{th (ch-c)}	1.25	°C/W
Thermal Resistance, Channel to Ambient	R _{th (ch-a)}	50	°C/W

Note:

- * Repetitive rating; Pulse Width Limited by Max. junction temperature.
- ** V_{DD} =25V, Starting T_{ch} =25 $^{\circ}$ C, L=71 μ H, R_{G} =25 Ω , $I_{AR} = 45A$

This transistor is an electrostatic sensitive device. Please handle with caution.

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ELECTRICAL CHARACTERISTICS (Ta = 25°C)

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CHARA	CTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Gate Leakage	e Current	$I_{ m GSS}$	$V_{GS} = \pm 16V, V_{DS} = 0V$	_	_	±10	μ A
Drain Cut-off	f Current	$I_{ m DSS}$	$V_{DS}=50V, V_{GS}=0V$	_	_	100	μ A
Drain-Source Voltage	Breakdown	V (BR) DSS	$I_D=10$ mA, $V_{GS}=0$ V	50	_	_	V
Gate Thresho	old Voltage	V_{th}	$V_{DS}=10V, I_{D}=1mA$	1.5	_	3.5	V
Drain-Source	ON Resistance	R _{DS} (ON)	$V_{GS} = 10V, I_D = 25A$	_	24	30	$\mathbf{m}\Omega$
Forward Train Admittance	nsfer	Y _{fs}	$V_{ m DS} = 10 V, \; I_{ m D} = 25 A$	15	27	_	S
Input Capacitance		Ciss		_	1250	_	
Reverse Transfer Capacitance		C_{rss}	$egin{array}{l} V_{ m DS}\!=\!10{ m V},\ V_{ m GS}\!=\!0{ m V} \ { m f}\!=\!1{ m MHz} \end{array}$	_	250	_	pF
Output Capacitance		Coss		_	700	_	
Switching Time	Rise Time	$\mathbf{t_r}$	$V_{\rm GS}$ $_{\rm 0V}$ $_{\rm 0V}$ $_{\rm RL}=$ $_{\rm 1.2\Omega}$ $_{\rm V_{\rm DD}=30V}$	_	20	_	
	Turn-on Time	t _{on}		_	30	_	ng
	Fall Time	t_f		_	40	_	ns
	Turn-off Time	t _{off}	$V_{ ext{IN}}: ext{t}_{ ext{r}}, ext{t}_{ ext{f}}{<}5 ext{ns}, \ ext{DD}$ 1867 Duty \leq 1%, $ ext{t}_{ ext{W}}{=}10\mu ext{s}$	_	120	_	
Total Gate Charge (Gate-Source Plus Gate-Drain)		$\mathbf{Q}_{\mathbf{g}}$	V _{DD} ≒40V, V _{GS} =10V	_	36	_	nC
Gate-Source Charge		$\mathbf{Q}_{\mathbf{g}\mathbf{s}}$	$I_{D}=45A$	_	22	_	
Gate-Drain ("Miller") Charge		\mathbf{Q}_{gd}		_	14	_	

SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Continuous Drain Reverse Current	$I_{ m DR}$	_	_	_	45	A
Pulse Drain Reverse Current	$I_{ m DRP}$	_	_	_	135	A
Diode Forward Voltage	$V_{ m DSF}$	I_{DR} =45A, V_{GS} =0V	_	_	-1.7	V
Reverse Recovery Time	t_{rr}	I_{DR} =45A, V_{GS} =0V	_	75	_	ns
Reverse Recovery Charge	Q_{rr}	$dI_{ m DR}/dt$ = 50A / $\mu m s$	_	75	_	nC

MARKING

